

Hearing Aid Compatibility (HAC) RF Emissions Test Report

APPLICANT : ZTE CORPORATION
EQUIPMENT : LTE Digital Mobile Phone
BRAND NAME : ZTE
MODEL NAME : Z839
FCC ID : SRQ-Z839
STANDARD : FCC 47 CFR §20.19
ANSI C63.19-2011

We, SPORTON INTERNATIONAL (KunShan) INC., would like to declare that the tested sample has been evaluated in accordance with the procedures and had been in compliance with the applicable technical standards.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL (KunShan) INC., the test report shall not be reproduced except in full.



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Revision History

REPORT NO.	VERSION	DESCRIPTION	ISSUED DATE
HA740501A	Rev. 01	Initial issue of report	May 25, 2017

**1. Attestation of Test Results**

Applicant Name	ZTE CORPORATION
Equipment Name	LTE Digital Mobile Phone
Brand Name	ZTE
Model Name	Z839
FCC ID	SRQ-Z839
HW Version	Z839HW1.0
SW Version	Z839V1.0.0B01
EUT Stage	Identical Prototype
HAC Rating	M4
Test Result	Pass

This device is compliance with HAC limits specified in guidelines FCC 47 CFR §20.19 and ANSI Standard ANSI C63.19.

2. Administration Data

Applicant	
Company Name	ZTE CORPORATION
Address	ZTE Plaza, Keji Road South, Hi-Tech Industrial Park, Nanshan District, Shenzhen, Guangdong, 518057, P. R. China
Manufacturer	
Company Name	ZTE CORPORATION
Address	ZTE Plaza, Keji Road South, Hi-Tech Industrial Park, Nanshan District, Shenzhen, Guangdong, 518057, P. R. China



3. Equipment Under Test Information

3.1 General Information

Product Feature & Specification	
Frequency Band	LTE Band 2: 1850 MHz ~ 1910 MHz LTE Band 4: 1710 MHz ~ 1755 MHz LTE Band 5: 824 MHz ~ 849 MHz LTE Band 13: 777 MHz ~ 787 MHz WLAN 2.4GHz Band: 2412 MHz ~ 2462 MHz Bluetooth: 2402 MHz ~ 2480 MHz
Mode	<ul style="list-style-type: none">• LTE: QPSK, 16QAM• 802.11b/g/n HT20• Bluetooth v3.0 + EDR, Bluetooth v4.0 LE

3.2 Air Interface and Operating Mode

Air Interface	Band MHz	Type	C63.19 Tested	Simultaneous Transmitter	OTT	Power Reduction
LTE	Band 2	VD	No ⁽¹⁾	WLAN, BT	Yes	No
	Band 4			WLAN, BT		No
	Band 5			WLAN, BT		No
	Band 13			WLAN, BT		No
WLAN	2450	VD	No ^(2,3)	LTE	Yes	No
BT	2450	DT	No	LTE	NA	No

VO=CMRS Voice Service

DT=Digital Transport

VD=CMRS IP Voice Service and Digital Transport

Remark:

1. LTE is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤ 17 dBm, and is rated as M4.
2. For 2.4GHz WLAN RF emissions testing exemption shall be applied to an RF air interface technology in a device whose Peak antenna input power, averaged over intervals $\leq 50 \mu s$, is ≤ 23 dBm.
3. No Associated T-Coil measurement has been made in accordance with KDB 285076 D02 T-Coil testing for CMRS IP.

3.3 Applied Standards

- FCC CFR47 Part 20.19
- ANSI C63.19 2011-version
- FCC KDB 285076 D01 HAC Guidance v04r01
- FCC KDB 285076 D02 T Coil testing for CMRS IP v02

4. HAC RF Emission

FCC wireless hearing aid compatibility rules ensure that consumers with hearing loss are able to access wireless communications services through a wide selection of handsets without experiencing disabling radio frequency (RF) interference or other technical obstacles.

To define and measure the hearing aid compatibility of handsets, in CFR47 part 20.19 ANSI C63.19 is referenced. A handset is considered hearing aid-compatible for acoustic coupling if it meets a rating of at least M3 under ANSI C63.19, and A handset is considered hearing aid compatible for inductive coupling if it meets a rating of at least T3.

According to ANSI C63.19 2011 version, for acoustic coupling, the RF electric field emissions of wireless communication devices should be measured and rated according to the emission level as below.

Emission Categories	E-field emissions	
	<960Mhz	>960Mhz
M1	50 to 55 dB (V/m)	40 to 45 dB (V/m)
M2	45 to 50 dB (V/m)	35 to 40 dB (V/m)
M3	40 to 45 dB (V/m)	30 to 35 dB (V/m)
M4	<40 dB (V/m)	<30 dB (V/m)

Table 4.1 Telephone near-field categories in linear units

5. Measurement System Specification

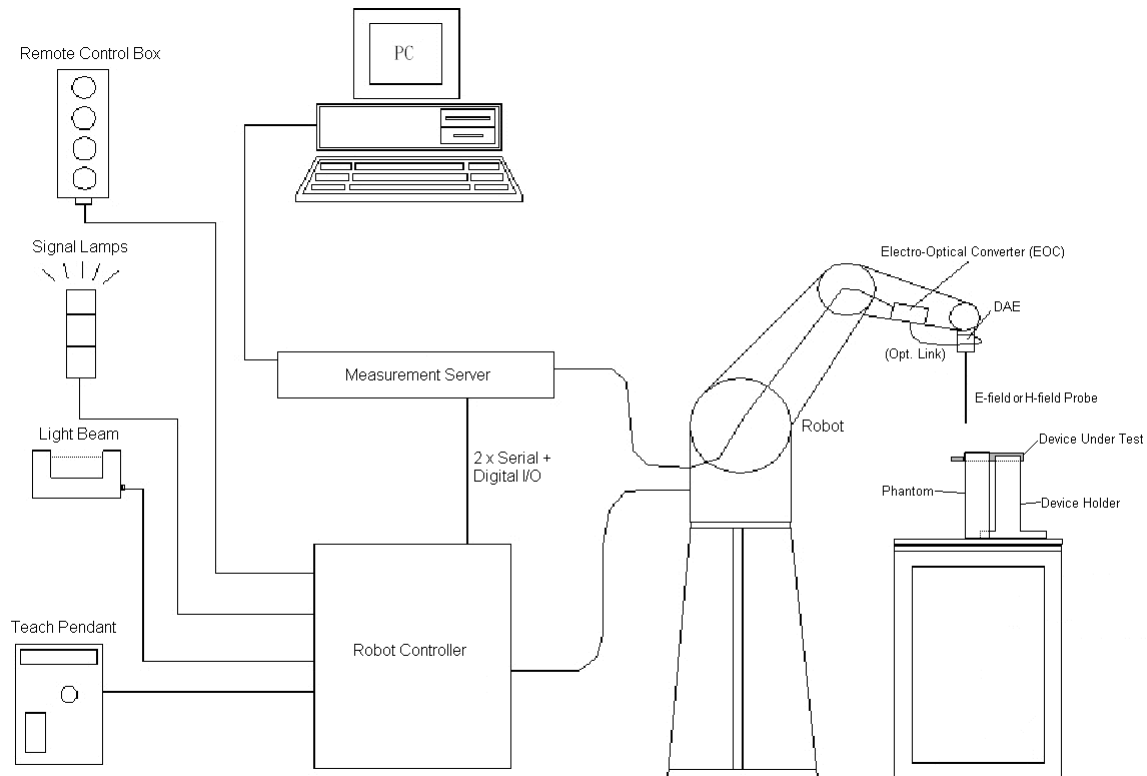


Fig 5.1 SPEAG DASY5 System Configurations

5.1 Test Arch Phantom

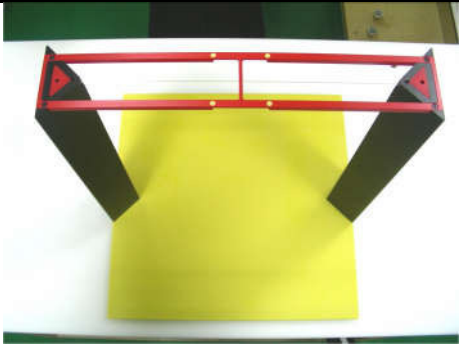
Construction :	Enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot.	
Dimensions :	370x 370 x 370 mm	

Fig 5.8 Photo of Arch Phantom

5.2 E-Field Probe System

E-Field Probe Specification

<ER3DV6>

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)
Frequency	100 MHz to 6 GHz; Linearity: ± 2.0 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to 1000 V/m (M3 or better device readings fall well below diode compression point)
Linearity	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm



Fig 5.2 Photo of E-field Probe

Probe Tip Description:

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

5.3 System Hardware

DAE

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit.

Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX90XL) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version (DASY5: CS8c) from Stäubli is used.

5.4 Data Storage and Evaluation

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, and device frequency and modulation data) in measurement files.

Probe parameters :	- Sensitivity	Norm _i , a _{i0} , a _{i1} , a _{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	dcp _i
Device parameters :	- Frequency	f
	- Crest factor	cf
Media parameters :	- Conductivity	σ
	- Density	ρ

The formula for each channel can be given as :

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with V_i = compensated signal of channel i, (i = x, y, z)
 U_i = input signal of channel i, (i = x, y, z)
 cf = crest factor of exciting field (DASY parameter)
 dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated :

$$\text{E-field Probes : } E_i = \sqrt{\frac{V_i}{\text{Norm}_i \cdot \text{ConvF}}}$$

with V_i = compensated signal of channel i, (i = x, y, z)
 Norm_i = sensor sensitivity of channel i, (i = x, y, z), $\mu\text{V}/(\text{V/m})^2$ for E-field Probes
 ConvF = sensitivity enhancement in solution
 f = carrier frequency [GHz]
 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude) :

$$E_{\text{tot}} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

6. Measurement System Validation

Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the test Arch and a corresponding distance holder.

6.1 Purpose of System Performance Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal HAC measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

6.2 System Setup

1. In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave which comes from a signal generator.
2. The center point of the probe element(s) is 15mm from the closest surface of the dipole elements.
3. The calibrated dipole must be placed beneath the arch phantom. The equipment setup is shown below:

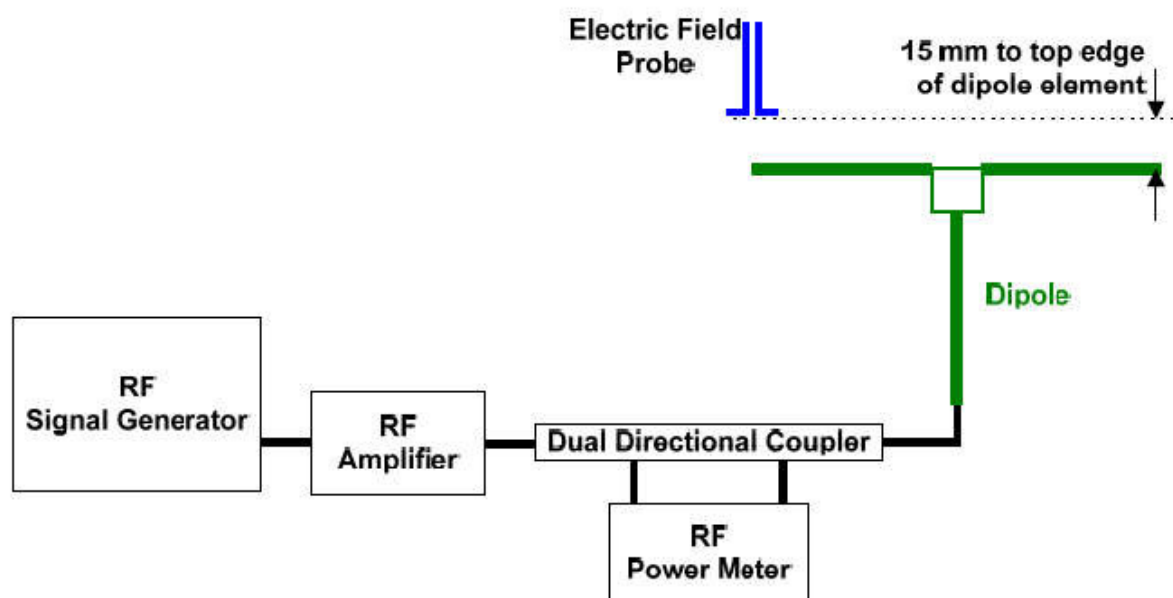


Fig. 6.1 System Validation Setup

The output power on dipole port must be calibrated to 20dBm (100mW) before dipole is connected.

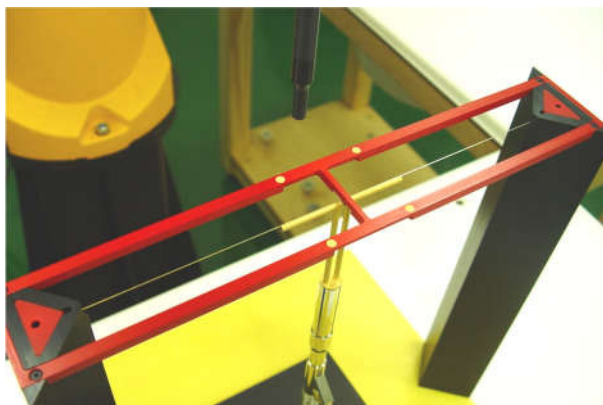


Fig 7.2 Dipole Setup



7. RF Emissions Test Procedure

Referenced from ANSI C63.19 -2011 section 5.5.1

- a) Confirm the proper operation of the field probe, probe measurement system, and other instrumentation and the positioning system.
- b) Position the WD in its intended test position.
- c) Set the WD to transmit a fixed and repeatable combination of signal power and modulation characteristic that is representative of the worst case (highest interference potential) encountered in normal use. Transiently occurring start-up, changeover, or termination conditions, or other operations likely to occur less than 1% of the time during normal operation, may be excluded from consideration.
- d) The center sub-grid shall be centered on the T-Coil mode perpendicular measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane, refer to illustrated in Figure 8.2. If the field alignment method is used, align the probe for maximum field reception.
- e) Record the reading at the output of the measurement system.
- f) Scan the entire 50 mm by 50 mm region in equality spaced increments and record the reading at each measurement point, The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- g) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- h) Identify the maximum reading within the non-excluded sub-grids identified in step g).
- i) *Indirect measurement method*
The RF audio interference level in dB (V/m) is obtained by adding the MIF (in dB) to the maximum steady-state rms field-strength reading, in dB (V/m)
- j) Compare this RF audio interference level with the categories in ANSI C63.19-2011 clause 8 and record the resulting WD category rating.
- k) For the T-Coil mode M-rating assessment, determine whether the chosen perpendicular measurement point is contained in an included sub-grid of the first scan. If so, then a second scan is not necessary. The first scan and resultant category rating may be used for the T-Coil mode M rating.

Otherwise, repeat step a) through step i), with the grid shifted so that it is centered on the perpendicular measurement point. Record the WD category rating.

Test Instructions

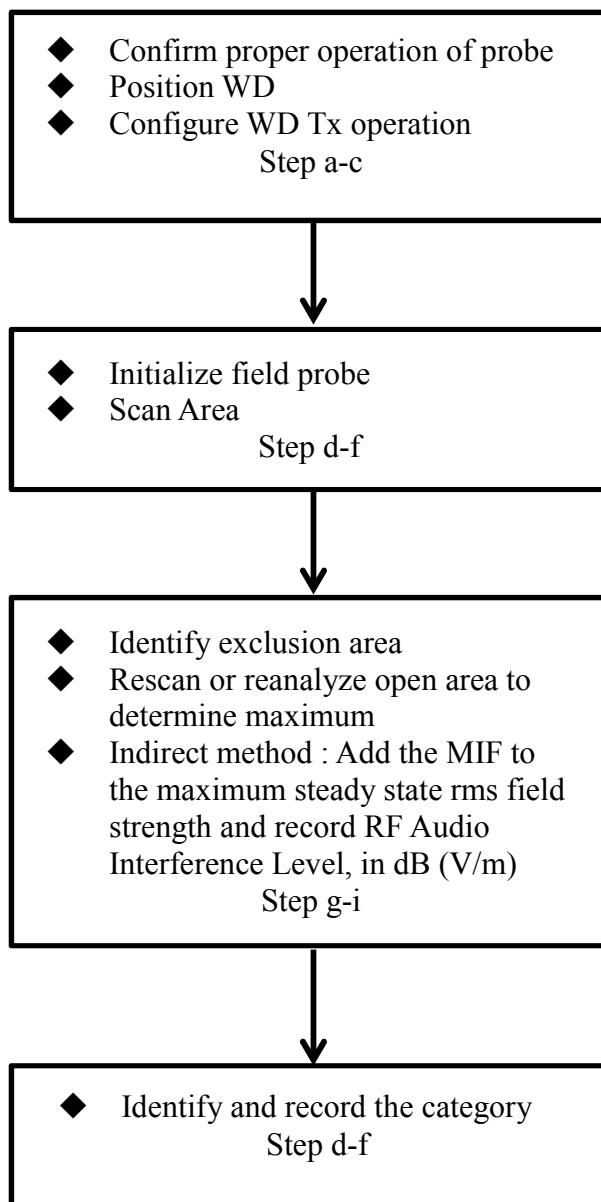


Fig 8.1 Flow Chart of HAC RF Emission



Fig 8.2 EUT reference and plane for HAC RF emission measurements

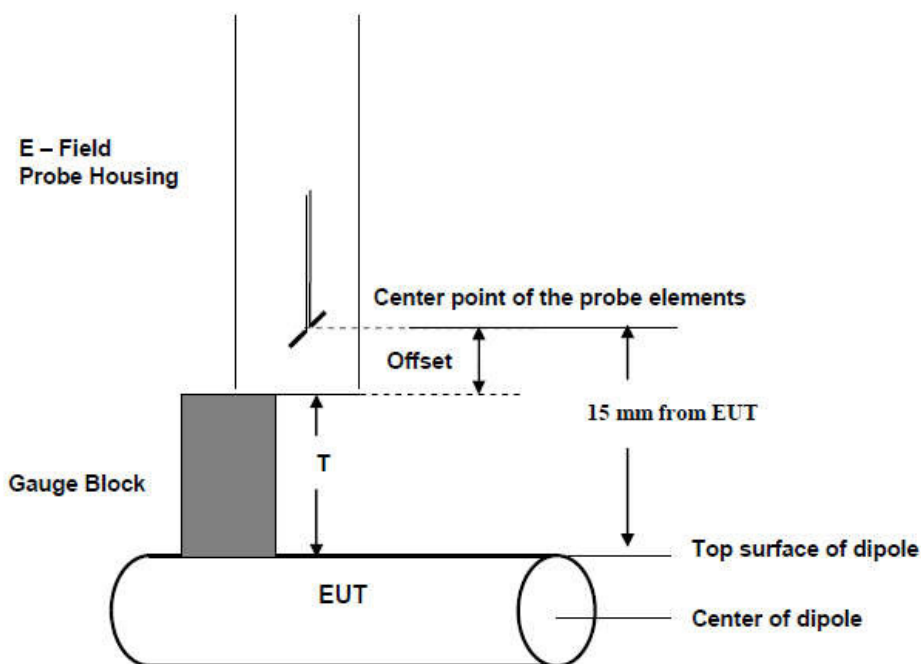


Fig. 8.3 Gauge block with E-field probe



8. Modulation Interference Factor

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF).

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be developed that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF

The Modulation Interference factor (MIF, in dB) is added to the measured average E-field (in dBV/m) and converts it to the RF Audio Interference level (in dBV/m). This level considers the audible amplitude modulation components in the RF E-field. CW fields without amplitude modulation are assumed to not interfere with the hearing aid electronics. Modulations without time slots and low fluctuations at low frequencies have low MIF values, TDMA modulations with narrow transmission and repetition rates of few 100 Hz have high MIF values and give similar classifications as ANSI C63.19-2011.

ER3D, EF3D and EU2D E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the indirect measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by PMR calibration in order to not overestimate the field reading. Probe Modulation Response (PMR) calibration linearizes the probe response over its dynamic range for specific modulations which are characterized by their UID and result in an uncertainty specified in the probe calibration certificate. The MIF is characteristic for a given waveform envelope and can be used as a constant conversion factor if the probe has been PMR calibrated.

The evaluation method for the MIF is defined in ANSI C63.19-2011 section D.7. An RMS demodulated RF signal is fed to a spectral filter (similar to an A weighting filter) and forwarded to a temporal filter acting as a quasi-peak detector. The averaged output of these filtering is scaled to a 1 kHz 80% AM signal as reference. MIF measurement requires additional instrumentation and is not well suited for evaluation by the end user with reasonable uncertainty. It may alternatively be determined through analysis and simulation, because it is constant and characteristic for a communication signal. DASY52 uses well-defined signals for PMR calibration. The MIF of these signals has been determined by simulation and it is automatically applied.



MIF values applied in this test report were provided by the HAC equipment provider, SPEAG, and the values are listed below

UID	Communication System Name	MIF(dB)
10021	GSM-FDD(TDMA,GMSK)	3.63
10011	UMTS-FDD(WCDMA)	-27.23
10039	CDMA2000 (1xRTT, RC1)	-19.77
10081	CDMA2000 (1xRTT, RC3)	-19.71
10295	CDMA2000 (1xRTT, RC1 SO3, 1/8th Rate 25 fr.)	3.26
10100	LTE-FDD(SC-FDMA,100%RB,20MHz,QPSK)	-23.48
10101	LTE-FDD(SC-FDMA,100%RB,20MHz,16-QAM)	-17.86
10108	LTE-FDD(SC-FDMA,100%RB,10MHz,QPSK)	-21.57
10109	LTE-FDD(SC-FDMA,100%RB,10MHz,16-QAM)	-16.87
10110	LTE-FDD(SC-FDMA,100%RB,5MHz,QPSK)	-23.39
10111	LTE-FDD(SC-FDMA,100%RB,5MHz,16-QAM)	-16.35
10139	LTE-FDD(SC-FDMA,100%RB,15MHz,QPSK)	-18.25
10140	LTE-FDD(SC-FDMA,100%RB,15MHz,16-QAM)	-19.37
10142	LTE-FDD(SC-FDMA,100%RB,3MHz,QPSK)	-22.36
10143	LTE-FDD(SC-FDMA,100%RB,3MHz,16-QAM)	-14.75
10145	LTE-FDD(SC-FDMA,100%RB,1.4MHz,QPSK)	-17.39
10146	LTE-FDD(SC-FDMA,100%RB,1.4MHz,16-QAM)	-13.6
10148	LTE-FDD(SC-FDMA,50%RB,20MHz,QPSK)	-18.28
10149	LTE-FDD(SC-FDMA,50%RB,20MHz,16-QAM)	-16.87
10154	LTE-FDD(SC-FDMA,50%RB,10MHz,QPSK)	-23.42
10155	LTE-FDD(SC-FDMA,50%RB,10MHz,16-QAM)	-16.36
10156	LTE-FDD(SC-FDMA,50%RB,5MHz,QPSK)	-21.71
10157	LTE-FDD(SC-FDMA,50%RB,5MHz,16-QAM)	-15.78
10160	LTE-FDD(SC-FDMA,50%RB,15MHz,QPSK)	-17.95
10161	LTE-FDD(SC-FDMA,50%RB,15MHz,16-QAM)	-17.54
10163	LTE-FDD(SC-FDMA,50%RB,3MHz,QPSK)	-19.99
10164	LTE-FDD(SC-FDMA,50%RB,3MHz,16-QAM)	-14.41
10166	LTE-FDD(SC-FDMA,50%RB,1.4MHz,QPSK)	-18.1
10167	LTE-FDD(SC-FDMA,50%RB,1.4MHz,16-QAM)	-12.15
10169	LTE-FDD(SC-FDMA,1RB,20MHz,QPSK)	-15.63
10170	LTE-FDD(SC-FDMA,1RB,20MHz,16-QAM)	-9.76
10175	LTE-FDD(SC-FDMA,1RB,10MHz,QPSK)	-15.63
10176	LTE-FDD(SC-FDMA,1RB,10MHz,16-QAM)	-9.76
10177	LTE-FDD(SC-FDMA,1RB,5MHz,QPSK)	-15.63
10178	LTE-FDD(SC-FDMA,1RB,5MHz,16-QAM)	-9.76
10181	LTE-FDD(SC-FDMA,1RB,15MHz,QPSK)	-15.63
10182	LTE-FDD(SC-FDMA,1RB,15MHz,16-QAM)	-9.76
10184	LTE-FDD(SC-FDMA,1RB,3MHz,QPSK)	-15.62
10185	LTE-FDD(SC-FDMA,1RB,3MHz,16-QAM)	-9.76
10187	LTE-FDD(SC-FDMA,1RB,1.4MHz,QPSK)	-15.62
10188	LTE-FDD(SC-FDMA,1RB,1.4MHz,16-QAM)	-9.76

The MIF measurement uncertainty is estimated as follows, declared by HAC equipment provider SPEAG, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

- i) 0.2 dB for MIF: -7 to +5 dB,
- ii) 0.5 dB for MIF: -13 to +11 dB
- iii) 1 dB for MIF: > -20 dB



9. Low-power Exemption

<Max Tune-up Limit>

LTE	Band 2	23.50
	Band 4	23.50
	Band 5	23.50
	Band 13	23.50
2.4GHz WLAN		15.50

<Low Power Exemption>

Air Interface	Max Average Antenna Input Power (dBm)	Worst Case MIF (dB)	Power + MIF(dB)	C63.19 test required
LTE Band 2	23.50	-9.76	13.74	No
LTE Band 4	23.50	-9.76	13.74	No
LTE Band 5	23.50	-9.76	13.74	No
LTE Band 13	23.50	-9.76	13.74	No

Air Interface	Max Average Antenna Input Power (dBm)	C63.19 test required
2.4GHz WLAN	15.50	No

General Note:

1. According to ANSI C63.19 2011-version, for WWAN RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤ 17 dBm for any of its operating modes.
2. For LTE operation the worst case MIF plus the worst case average antenna input power for all modes are investigated to determine the testing requirements for this device.
3. According to ANSI C63.19 2011, for WLAN RF emissions testing exemption shall be applied to an RF air interface technology in a device whose Peak antenna input power, averaged over intervals $\leq 50 \mu s$, is ≤ 23 dBm.
4. HAC RF rating is M4 for the air interface which meets the low power exemption.

Test Engineer : Nick Hu.



10. References

- [1] ANSI C63.19-2011, "American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids", 27 May 2011.
- [2] FCC KDB 285076 D01v04r01, "Equipment Authorization Guidance for Hearing Aid Compatibility", Apr 2016
- [3] FCC KDB 285076 D02v02, "Guidance for Performing T-Coil tests for Air Interfaces Supporting Voice over IP", Apr 2016
- [4] SPEAG DASY System Handbook